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Subject: Today's Must-Read News

January 5, 2017

NAS Report Finds New Methods Will Advance, Challenge EPA Risk Analyses

The National Academy of Sciences (NAS) in a just-released report says new toxicology and exposure technologies have the potential to advance more complex regulatory risk assessment, including evaluation of the effects of multiple and non-chemical stressors, but also outline a series of challenges these new methods will pose for EPA and other agencies.

DOJ Argues Superfund Bars Citizens' Challenge Of Indiana Lead Cleanup

The Department of Justice (DOJ) is asking a federal district court to dismiss litigation brought by citizens who want EPA to more broadly address cumulative impacts from lead at an East Chicago, IN, Superfund site that has drawn comparisons with the high levels of lead in drinking water in Flint, MI, and regulators' mishandling of that response.

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